

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/743,850 CHEN ET AL.	
		Examiner	Art Unit DAVID CZEKAJ	2621 Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-5,802,063	09-1998	Deiss, Michael Scott	370/476
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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